

Exploring Emerging Memory Technologies in Modern Electronics

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KEYWORDS:

Emerging Memory Technologies; ReRAM (Resistive RAM); MRAM (Magnetoresistive RAM); Phase-Change Memory (PCM); Ferroelectric RAM (FeRAM); Non-Volatile Memory; Modern Electronics

ARTICLE HISTORY:

Received : 19.11.2024
Revised : 21.12.2024
Accepted : 12.06.2025

<https://doi.org/10.31838/ECE/02.02.04>

ABSTRACT

Emerging memory technologies are poised to revolutionize modern electronics by overcoming the limitations of traditional memory solutions like DRAM and NAND flash. These innovative technologies offer significant advancements in speed, energy efficiency, scalability, and data retention. Resistive RAM (ReRAM) uses resistive switching to store data, providing faster read and write speeds, and is ideal for IoT and wearable devices due to its low power consumption and non-volatility. Magnetoresistive RAM (MRAM) leverages magnetic states to store information, offering high speed, endurance, and non-volatility, making it suitable for applications requiring data persistence such as in automotive and aerospace sectors. Phase-Change Memory (PCM) exploits the reversible switching between amorphous and crystalline states in chalcogenide glass, delivering high storage density and fast access times, beneficial for next-generation computing and data centers. Ferroelectric RAM (FeRAM) utilizes ferroelectric materials to achieve rapid write speeds and low power consumption, with applications in smart cards and security systems. As these technologies continue to evolve, they are expected to become integral components of future electronic devices, driving advancements in artificial intelligence, big data analytics, and ubiquitous computing, and thereby pushing the boundaries of modern electronics towards more efficient, faster, and reliable memory solutions.

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How to cite this article: Usikalu MR, Alabi D, Ezeh GN. Exploring Emerging Memory Technologies in Modern Electronics. Journal of Progress in Electronics and Communication Engineering, Vol. 2, No. 2, 2025 (pp. 31-40).

INTRODUCTION

The realm of memory electronics has advanced remarkably, propelling innovations across diverse fields like MEMS, augmented reality, virtual reality, and neuromorphic computing.^[1] Emerging nonvolatile memory technologies, such as MRAM, STT-RAM, FeRAM, PCM, and RRAM, offer an enticing blend of SRAM's speed, DRAM's density, and the non-volatile nature of Flash memory - making them attractive candidates for future memory hierarchies.^[1] Additionally, novel classes like transparent, plastic, 3D, and quantum dot memory have gained significant traction in recent years, fostering advancements in MLC, NVRS, and non-volatile memory applications as illustrated in Fig. 1.

This article delves into the burgeoning landscape of emerging memory technologies in modern electronics. It explores market and technology trends, the context and drivers fueling the need for these innovations, and

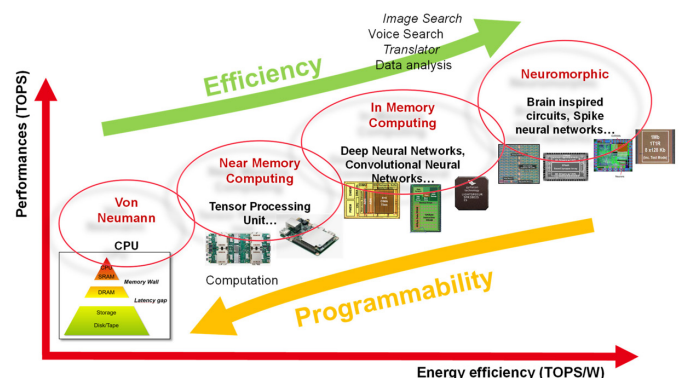


Fig. 1: Advances in Emerging Memory Technologies

provides an overview of prominent emerging memories. Furthermore, it examines the diverse applications harnessing these technologies, their role in neuromorphic architectures, and concludes with insights into the future trajectory of this dynamic field.^[2-4]

MARKET AND TECHNOLOGY TRENDS

The non-volatile memory market has witnessed remarkable growth, driven by the increasing demand for durable and energy-efficient memory solutions across various industries, including automotive, consumer electronics, and healthcare.^[5-6] The proliferation of Internet of Things (IoT) devices and the rising adoption of artificial intelligence (AI) and machine learning (ML) technologies have further fueled this market's expansion.^[7-9]

A. Non-volatile Memory Market

The non-volatile memory market has entered a growth phase and is expected to continue its upward trajectory in the coming years.^[10] This growth can be attributed to the growing demand for applications across diverse sectors, such as automotive, transportation, military, aerospace, industrial, communication, energy, electricity, medical, agricultural, and retail.^[11]

Based on product types, the market is categorized into several segments, including EEPROM, NVSRAM, embedded, EPROM, 3D NAND, and MRAM/STT-MRAM, with these categories holding the largest market share in 2023.

B. Evolution of Standalone Non-volatile Memory Technologies

- Flash Memory Dominance:** Flash technologies have dominated the non-volatile memory market, exceeding \$50 billion in 2019 and comprising the largest product segment of the worldwide semiconductor industry. Samsung has emerged as the world's largest supplier of Flash chips, capturing around 30% of the market share, while other major vendors include Toshiba and Western Digital.
- NOR and NAND Flash:** NOR Flash architecture offers advantages of random access and short read times, making it ideal for code execution and data processing applications. On the other hand, NAND Flash has a slower read speed but a

much smaller cell size, enabling higher density devices at lower cost per bit, making it suitable for mass storage applications.

- Market Dynamics:** By the late 1980s, the worldwide market for semiconductor non-volatile memory devices surpassed \$2 billion, with US manufacturers like AMD, Intel, Motorola, SEEQ, and TI supplying about 50% of the revenue. European and Japanese suppliers accounted for the remaining market share.
- Technology Advancements:** Vendors are continuously developing new solutions with improved capabilities. For instance, in February 2021, Kioxia Corporation and Western Digital Corp. announced the development of a sixth-generation, 162-layer 3D flash memory technology, utilizing various technology and manufacturing innovations.
- NOR Flash Traction:** NOR Flash memory is gaining traction due to its ultra-low-power needs. In January 2022, Infineon Technologies announced additional development tools to support its family of SEMPER NOR Flash devices, enabling developers to design safety-critical and inherently secure automotive, industrial, and communication systems.

C. Trends in Embedded Non-volatile Memory Technologies

- Integration with AI and ML:** The integration of embedded non-volatile memory (eNVM) with AI and ML is revolutionizing the way devices operate. By 2024, it is estimated that 60% of edge devices will be equipped with AI capabilities, enabling them to perform complex tasks like real-time language translation and predictive maintenance. These devices, with in-built eNVM, are expected to process data 10 times faster than those relying on traditional cloud-based systems as illustrated in Fig. 2.

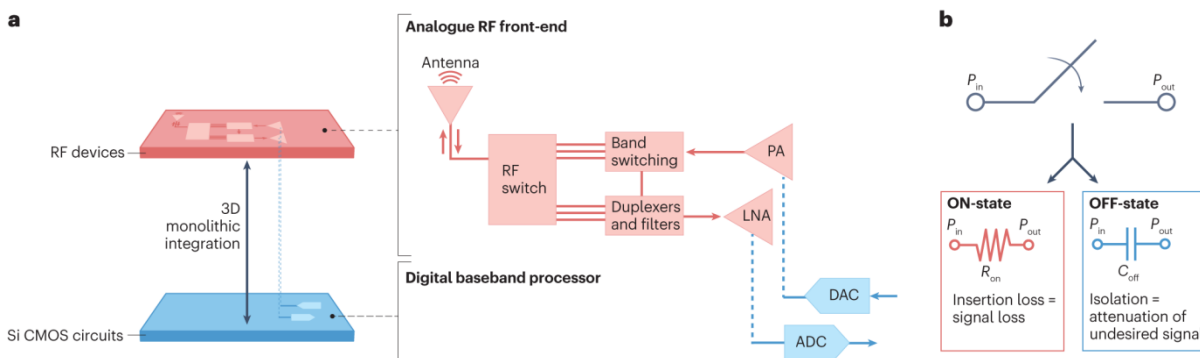


Fig. 2: Non-volatile radiofrequency switching technologies

2. **Enhanced Security:** Security concerns are ever-present in the digital age. The latest eNVM technologies have introduced features like 256-bit encryption and unique device identifiers, making each chip virtually tamper-proof. For example, in the financial sector, these advancements have led to a 40% reduction in data breaches related to consumer electronics within just one year, demonstrating the critical role of eNVM in protecting user privacy and enhancing device security.
3. **Scalability Challenges:** While advancements are being made, some eNVM technologies currently struggle to achieve the same level of scalability as established memory options like NAND flash. This can limit their applicability in certain high-density storage applications where scalability is paramount. Manufacturers need to invest in research and development efforts to enhance the scalability of eNVM technologies, enabling them to meet the growing demands of emerging applications such as big data analytics and artificial intelligence.
4. **Regional Developments:** The Asia Pacific region is witnessing significant growth in the construction of new infrastructure, including data centers, owing to a surge in demand for online entertainment, telecommuting, and video and voice call services. China has emerged as a leading country in the NAND memory business, with companies like Yangtze Memory Technologies Co. Ltd (YMTC) shipping 64 layers of NAND domestically in low volumes, including SSDs, with 128-layer production in development.
5. **Investments and R&D Activities:** Startups in the Asia Pacific region engaged in developing non-volatile memory technologies are receiving substantial investments. For instance, in April 2021, InnoStar Semiconductor (Shanghai) Co. Ltd raised around \$100 million in a pre-series A financing round. [5] Additionally, the region is witnessing an increase in R&D activities in non-volatile memory. In January 2022, Samsung Electronics demonstrated one of the world's first in-memory computing based on MRAM (Magnetoresistive Random Access Memory).

CONTEXT AND DRIVERS FOR EMERGING MEMORIES

A. The Era of Big Data

The world is witnessing an unprecedented surge in data generation. More than two trillion gigabytes

(109 bytes) of data are created each day, and this volume is expected to grow exponentially, reaching a staggering 175 zettabytes (ZB) by 2025 - four times more than what we use today. People are forecasted to carry more than four mobile devices, and 75% of the worldwide population will be connected to the network.

Apart from the sheer volume, data comes in various forms, ranging from photos and videos to audio recordings, email messages, documents, books, presentations, tweets, and more, often in an unstructured format. This diversity adds to the complexity of data management and processing.^[12]

B. Exponential Increase in Required Energy

The rapid growth of data generation has led to a corresponding increase in energy demands. Data-heavy technologies, such as ChatGPT and the metaverse, have become integral parts of our daily lives, posing significant challenges for semiconductor companies to advance their products and meet the rising technological demands.

Researchers have developed a new design for computer memory that could both greatly improve performance and reduce the energy demands of internet and communications technologies, which are predicted to consume nearly a third of global electricity within the next ten years. This explosion in energy demands is largely due to shortcomings of current computer memory technologies.

C. Limitations of Computing Systems

In conventional computing systems, there is a clear separation between memory and processing units, necessitating the constant shuttling of data between the two components. This data movement represents a significant overhead in computation, often exceeding the energy required for on-chip digital data processing.

The limitations of traditional computing architectures have led to the exploration of two potential solutions:

1. **Optimizing Data Throughput:** Approaches like high bandwidth memory (HBM) and hybrid memory cube (HMC) aim to optimize data throughput in a multi-chip approach.
2. **In-Memory Computing (IMC):** This paradigm shift involves enabling in-situ computation of data within the memory itself, radically changing the computing paradigm and eliminating the need for data movement between separate memory and processing units as illustrated in Fig. 3.

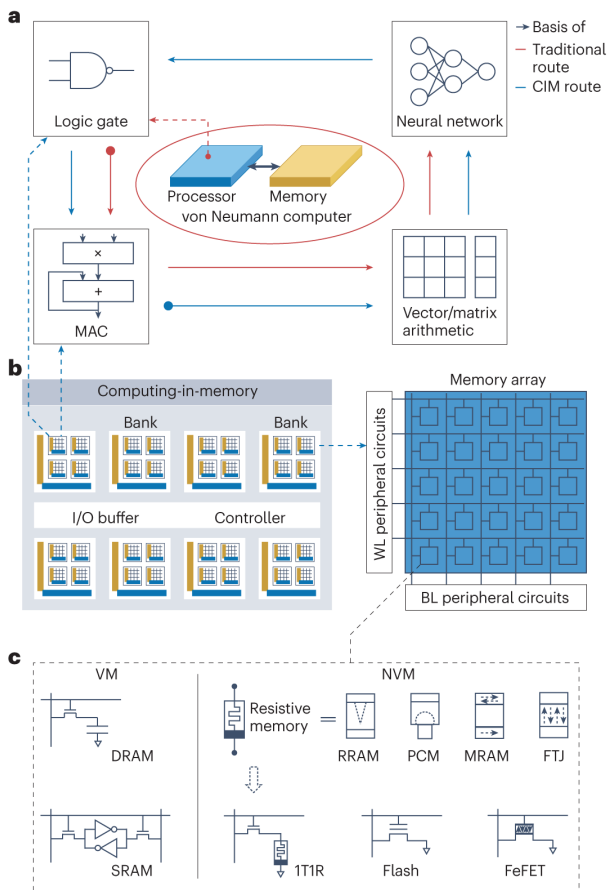


Fig. 3: A full spectrum of computing-in-memory technologies

D. Development of New Computing Systems

To address the challenges posed by the data explosion era, researchers and industry experts are exploring new computing systems that go beyond the traditional von Neumann architecture. These systems aim to be more memory-centric and distributed, leveraging emerging memory technologies to enable in-memory computing (IMC) and analog-compute in memory (ACIM).

The development of these new computing systems is driven by the need for higher performance, lower power consumption, and higher capacity, as well as the ability to effectively eliminate issues inherent to the memory wall. Emerging memories, such as resistive random-access memory (RRAM), phase-change memory (PCM), and ferroelectric RAM (FeRAM), have attracted considerable interest for IMC applications due to their non-volatile storage capabilities, high density, and fast programming and read operations.^[13]

By breaking down the boundaries between computation and memory, emerging memory solutions are set to play a critical role in realizing the “Beyond Memory” era, paving the way for energy-efficient AI accelerators and next-generation computing paradigms.

OVERVIEW OF EMERGING MEMORY TECHNOLOGIES

A. Filamentary Memory (RRAM and CBRAM)

Resistive random-access memory (RRAM) is a promising candidate for next-generation memory applications, offering the switching speed of SRAM, high storage density comparable to DRAM, and non-volatility akin to Flash memory. RRAM comprises a simple metal-insulator-metal (MIM) structure, with a switching material sandwiched between two metal electrodes. The resistance of this insulating layer can be varied between a high resistance state (HRS) and a low resistance state (LRS) to store data by forming and rupturing conductive filaments.

RRAM is classified into two types based on the switching mechanisms: metal oxide random access memory (OxRAM) and conductive bridge random access memory (CBRAM). In OxRAM, the switching layer is a metal oxide, and the switching mechanism involves the formation and rupture of oxygen vacancy-based conductive filaments. Conversely, in CBRAM, the switching layer is a solid

	PCM		RRAM			MRAM		
	STM	Panasonic	TSMC	Intel	TSMC	Intel	Samsung	GF
Node	28 FDSOI	40nm	N22	22FFL	N22	22FFL	28 FDSOI	22nmFDSOI
Capacity	16MB	2Mb	3.6Mb	3.6Mb	32Mb	7Mb	1Gb	40Mb
Cell size	0.036um ²	?	0,0424um ²	0,0486um ²	0,0456um ²	0.0486um ²	0.036um ²	?
Endurance	200kc	100kc	10kc	10kc	100kc-1Mc	1Mc	1Mc	1Mc
Retention	150°C	85°C 10ys	85°C 10ys	85°C 10ys	150°C 10ys	200°C 10ys	105°C 10ys	105°C 10ys
Transistor	5V	?	1.62-3.63V	1.5V-3.6V	1.62-3.63V	?	1-1.8V	0.8-1.5V?
Application	Automotive microcontrollers	Embedded	eFlash, IoT, smartcard	Mobile and RF	eFlash, automotive	Embedded	Embedded	Industrial-grade MCU and IOT

Fig. 4: Advances in Emerging Memory Technologies

electrolyte, and the switching mechanism involves the migration of metal ions and the formation/dissolution of metallic conductive filaments.^[14]

CBRAM offers excellent switching performance, including fast switching, low power consumption, low operating voltage (<1V), multi-level cell (MLC) storage, and versatile switching characteristics suitable for volatile memory, non-volatile memory, and neuromorphic applications. However, challenges such as poor retention, low endurance, and highly stochastic switching need to be addressed as illustrated in Fig. 4.

B. Phase Change Memory (PCRAM)

Phase-change memory (PCRAM or PCM) is a non-volatile memory technology that exploits the unique behavior of chalcogenide glass. In PCRAM, heat generated by an electric current is used to switch the chalcogenide material between amorphous (high resistance) and crystalline (low resistance) states, representing binary data.

The most commonly used phase-change material is Ge₂Sb₂Te₅ (GST), a chalcogenide alloy of germanium, antimony, and tellurium. When heated above 600°C and rapidly cooled, GST transitions to an amorphous state with high resistance. Heating it above the crystallization point but below the melting point allows it to transform into a crystalline state with low resistance.

Recent advancements include the ability to control the material state more precisely, enabling four distinct states: amorphous, crystalline, and two partially crystalline states. This allows a single cell to represent two bits, doubling the memory density. PCRAM offers higher performance for applications requiring fast writing, as single bits can be changed without erasing entire blocks. However, PCRAM devices degrade with use, though at a slower rate than Flash memory.

PCRAM is actively researched for in-memory computing applications, leveraging its analog storage capability and Kirchhoff's circuit laws to perform computational tasks like matrix-vector multiplication within the memory array itself. This could be advantageous for applications like deep learning inference that do not require high computing precision.^[15]

C. Magnetic Memory (STT-MRAM and SOT-MRAM)

Magneto-resistive random access memory (MRAM) is a non-volatile memory technology that stores binary information based on the relative magnetization state of two ferromagnetic layers. Different flavors of MRAM

have emerged, making it increasingly attractive for cache applications and in-memory computing. Spin-transfer torque MRAM (STT-MRAM) uses a current to induce switching of the free magnetic layer, offering a promising alternative to SRAM for cache memory. Spin-orbit torque MRAM (SOT-MRAM) differs in its current injection geometry, with the write current flowing in-plane through an adjacent heavy metal layer, decoupling the programming from the read path.

SOT-MRAM promises faster write speeds (3-10ns) and longer endurance compared to STT-MRAM, as the programming mechanism does not damage the magnetic tunnel junction (MTJ). However, the value of faster write times is debated, as memories are typically read more often than written. Voltage-controlled magnetic anisotropy (VCMA)-MRAM and voltage-gate assisted spin-orbit torque (VG-SOT) MRAM explore using electric fields or a combination of VCMA and SOT effects for writing, further reducing power consumption. Domain-wall MRAM devices, encoding information in magnetic domain walls, are also being explored for higher density. As embedded memories, MRAM technologies require fewer additional processing steps compared to embedded Flash or DRAM, making them attractive for integration with CMOS logic processes. While SOT-MRAM may initially complement STT-MRAM, foundries could offer both flavors to customers.

D. Ferroelectric Memory (FeRAM and FeFET)

Ferroelectric random access memory (FeRAM) and ferroelectric field-effect transistors (FeFETs) are emerging memory technologies that leverage the ferroelectric properties of certain materials. In FeRAM, data is stored by polarizing the ferroelectric material in one of two stable polarization states, representing binary values. FeFETs, on the other hand, integrate a ferroelectric layer into the gate stack of a field-effect transistor, enabling non-volatile storage of data.

These technologies offer advantages such as non-volatility, high read/write speeds, low power consumption, and high endurance. However, challenges like scaling limitations, imprint issues, and integration with CMOS processes need to be addressed for widespread adoption.

E. Emerging Memory Benchmark

As emerging memory technologies continue to evolve, benchmarking their performance against established memory types becomes crucial. Key metrics for comparison include read/write speeds, endurance (number of write cycles), retention time, power consumption, scalability,

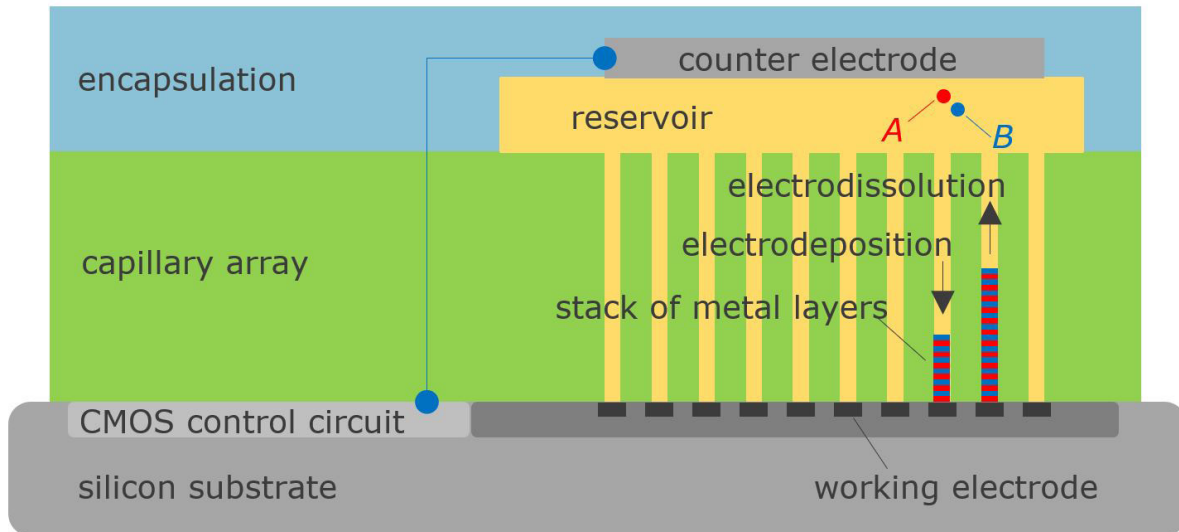


Fig. 5: Liquid-based memories

and integration with existing CMOS processes. While each emerging memory technology offers unique advantages, trade-offs exist between various performance metrics. For instance, RRAM and PCRAM offer high density and low power consumption but may face endurance challenges. MRAM technologies like STT-MRAM and SOT-MRAM excel in read/write speeds and endurance but may have higher power consumption. Ultimately, the suitability of an emerging memory technology will depend on the specific application requirements, such as prioritizing density, speed, endurance, or power efficiency. Comprehensive benchmarking and analysis are essential to guide the development and adoption of these technologies in future memory hierarchies and computing architectures [16]-[17] as illustrated in Fig. 5.

3. APPLICATIONS OF EMERGING MEMORIES

A. Evolution of Von Neumann Computing Systems

The von Neumann architecture, which separates memory and processor units, has been a severe conceptual constraint for the further growth of traditional computing systems. This separation leads to the von Neumann bottleneck, where the limited throughput between the central processing unit (CPU) and memory becomes a bottleneck, significantly impacting effective processing speed when dealing with large amounts of data.

Several methods have been proposed to mitigate this bottleneck, including caching, separate data and instruction paths (Modified Harvard architecture), branch prediction algorithms, on-chip scratchpad memory, and system-on-chip designs. However, the exponential increase in data generation and the associated energy demands have necessitated the

development of alternative computational approaches for future nanoelectronics.

B. Emerging Memories for Non-Von Neumann Systems

The majority of proposed solutions involve computational system designs loosely based on the human brain structure, including in-memory computing, where memory and processing units are collocated. This approach eliminates the redundancy associated with data traffic by performing computational tasks and data storage in the memory itself.

From a material science perspective, exploring the potential of emerging nanomaterials could enable the much-needed departure from conventional approaches and is particularly promising in the context of neuromorphic computing. Two-dimensional (2D) materials and their van der Waals heterostructures offer the possibility of integration with existing Si complementary metal-oxide-semiconductor (CMOS) technology, in-memory computing platforms, and matrix computing for artificial neural networks and spiking neural networks applications.

C. Novel Functions

Emerging memories, such as resistive random-access memory (RRAM), phase-change memory (PCM), and ferroelectric RAM (FeRAM), have attracted considerable interest for in-memory computing (IMC) applications due to their non-volatile storage capabilities, high density, and fast programming and read operations.

These memories can be used in various capacities, including as a replacement for flash technology, as

storage class memories (SCM) between main memory and flash/disks, or as a DRAM companion chip or replacement in the main memory area. [13] They offer benefits such as improved data integrity management, increased capacity for big data applications, and simplified atomic operations in transactional databases. Additionally, emerging memories have been explored for applications in digital neural networks, analog deep learning accelerators, and spiking brain-inspired neural networks. For instance, OxRAM has been used for inference in deep neural networks (DNNs), leveraging its high reading operations capability while requiring only a limited number of cycles.

D. In/Near Memory Computing

In-memory computing (IMC) has emerged as a new computing paradigm capable of alleviating or suppressing the memory bottleneck, a major concern for energy efficiency and latency in modern digital computing. Various IMC concepts have been proposed, ranging from conventional von Neumann architectures with separate memory and computing to near-memory computing (NMC), where embedded non-volatile memory (eNVM) is integrated on the same chip as the computing unit, and true IMC, where SRAM is used directly as a computational engine.

The ultimate concept is IMC within the eNVM, which appears to be the most promising approach to minimize data movement, energy consumption, and latency, although challenges and trade-offs exist in terms of throughput, energy efficiency, and accuracy of the processing. Emerging memories represent a promising approach for eNVM in IMC due to their attractive properties, such as scaling, 3D integration, and non-volatile storage of computing parameters as illustrated in Fig. 6.

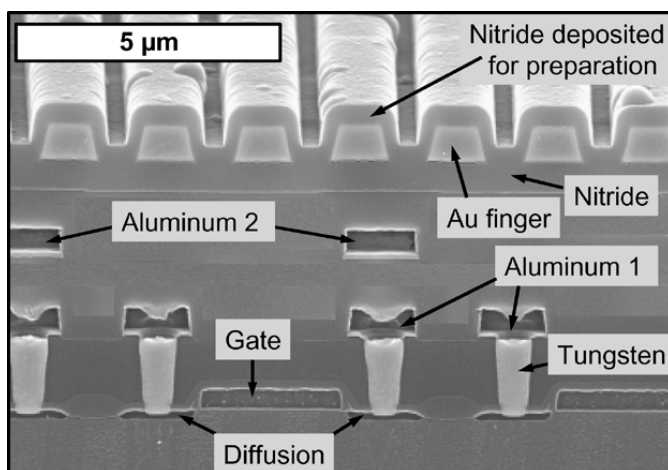


Fig. 6: SEM cross section of the chip.

In today's data-centric world, where data fuels numerous application domains, with machine learning at the forefront, handling the enormous volume of data efficiently in terms of time and energy presents a formidable challenge. Computing near-memory (CNM) and computing-in-memory (CIM) have emerged as potentially game-changing paradigms, with the core concept of performing computations within or near the memory itself.^[18-19] CNM systems integrate specialized CMOS logic into the memory chip, either general-purpose or domain-specific, while CIM nearly eliminates data movement by performing computations within the same devices that store the data. CIM enables operations like analog dot-product in memory, which is of significant importance to the machine learning domain and can be performed in constant time.

Initially demonstrated in crossbar-configured resistive non-volatile memory (NVM) technologies like PCM and RRAM, the concept of CIM has also been shown with SRAM, magnetic RAM (MRAM), and ferroelectric field-effect transistor (FeFET). While other arithmetic, search, and boolean logic operations have also been demonstrated using CIM, they have received comparatively less attention.

NEUROMORPHIC ARCHITECTURES

Since the advent of artificial intelligence (AI), the demand for neuromorphic computing in memory technology has been increasing rapidly with innovation in algorithms and advanced computational technologies. By integrating analog computing, information storage, and mimicking biological functions, neuromorphic computing systems have achieved significant progress in emulating the human brain at the device level. Concerning device systems, field effect transistors (FETs) are considered the primary devices for integrated systems to be utilized in computers for modern information technology and industrial innovation.^[19]

A. Electro-Chemical Random Access Memory (ECRAM)

Figure 3(g) schematically shows the electro-chemical random access memory (ECRAM), where the conductivity of a metal-oxide transistor channel can be changed by ionized defects injection across the vertical stack, consisting of a reservoir layer and a solid-state electrolyte layer. Defects might consist of oxygen vacancies, Li ions, or protons. Organic materials have also been explored, demonstrating various synaptic and neuronal functionalities. Similar to SOT-MRAM, the three-terminal ECRAM structure allows decoupling the read and write paths, thus improving cycling endurance and reducing energy consumption thanks to the extremely

low conductivity of the metal oxide channel, e.g., WO₃. Controllable and linear potentiation characteristics were reported, which makes ECRAM a promising technology for synaptic devices in neuromorphic devices capable of learning and training. 3D vertical ECRAM has also been demonstrated, paving the way for ECRAM-based high-density cross-point arrays.^[20]

B. Memtransistor Devices

Figure 3 shows the memtransistor devices combine the three-terminal transistor structure with the memristor-like ability to change the channel conductance by the application of an in-plane drain-source voltage.^[19] Typical memtransistors consist of a FET with a 2D semiconductor channel, such as MoS₂. The memory behavior is obtained by applying large source-drain voltages, which can induce the resistance change by various physical mechanisms, such as:

1. Field-induced dislocation migration in the polycrystalline MoS₂ channel
2. The dynamic tuning of the Schottky barrier at the metal-semiconductor contact
3. The direct cation migration from the electrodes on the surface of a 2D semiconductor

Other implementations of memtransistors exploit the optical properties of the 2D material (typically, a

transition metal dichalcogenide) to develop devices with neural properties. Similar neuromorphic devices were obtained exploiting the ionic diffusion on amorphous oxides, such as ZnO or indium tungsten oxide (IWO). The major advantage of the memtransistor is the three-terminal structure, the atomically thin channel, and the 3D integration in the back end. However, compared to all the other reported technologies, memtransistors are still in their early stage of development, with significant challenges on materials, device structures, and reliability^[21] as illustrated in Fig. 7.

C. Dynamic In-Memory Computing (IMC)

Dynamic IMC, schematically shown in Fig. 4, generally combines all the opportunities of static IMC with the additional strength of enabling controlled switching of the memory devices to reproduce additional functions, such as neuron activation,^[15] stateful Boolean logic, and learning in supervised/unsupervised neural networks.^[8-10] A wide range of physical mechanisms can be used for the controlled switching, such as:

- Filament plasticity in RRAM devices
- Gradual crystallization in PCM devices
- Charge trapping in MoS₂ memtransistors [10]
- Magnetic polarization for true-random number generation (TRNG) [14]

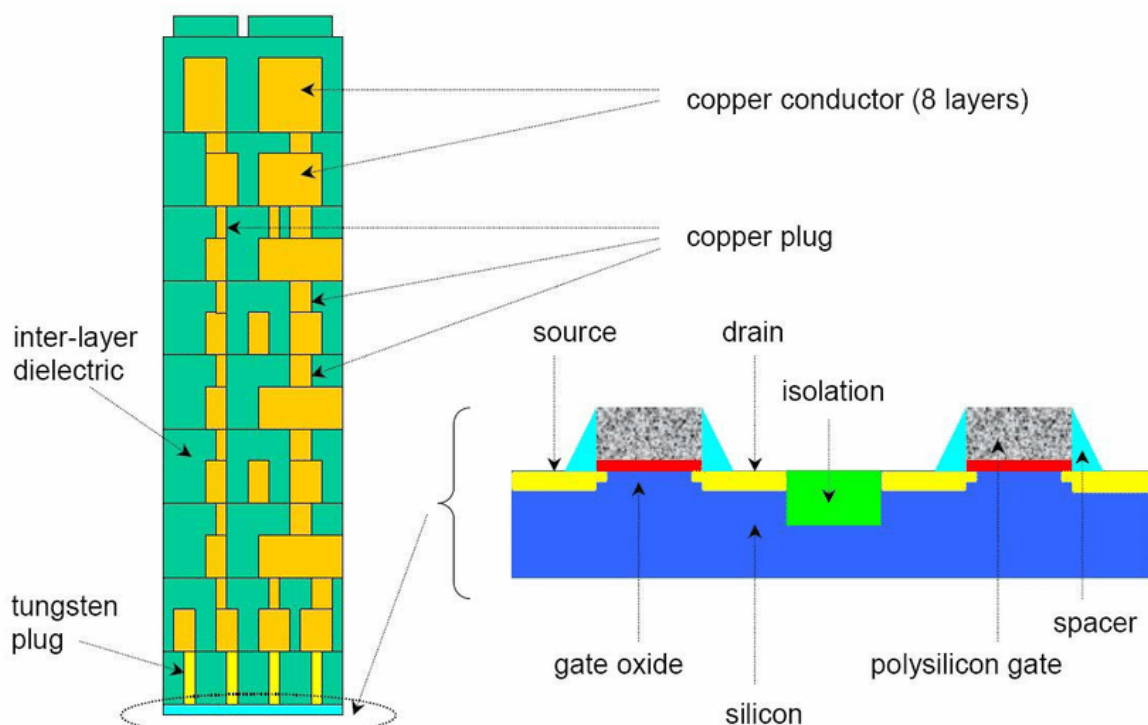


Fig. 7: General representation of IC cross section

Dynamic IMC provides a promising avenue for reducing latency, energy, and circuit area by leveraging the intrinsic device physics of the device instead of emulating the desired characteristics via the analog/digital design of CMOS-based networks.^[15] Dynamic and static IMC are generally combined in the same platform to provide energy-efficient computing systems capable of learning and adaptation.^[5-16] Applications of dynamic IMC include outer product accelerators for neural network training (Sec. VII) and neuromorphic systems for brain-inspired computing.^[22-24]

D. RRAM-based Bayesian Networks

The conceptual scheme of an RRAM-based Bayesian network where each synaptic weight belongs to a certain distribution. Figure 8 shows a possible implementation in an $N \times M$ array of RRAM synapses with 1T1R structures. Here, the distribution of a synaptic parameter is modeled by the distribution of conductance states of N devices in a column, while the input voltages to each column are the outputs generated by M neurons in the previous layer. By applying a voltage vector across M columns, each row yields a current that flows into a neuron circuit, resulting in a distribution of N neuron activation voltages, namely, the output distribution of the neuron. Based on the same approach, Monte Carlo Markov chain (MCMC) networks have been demonstrated with stochastic RRAM arrays.

CONCLUSION

The realm of emerging memory technologies is undergoing a remarkable transformation, driven by the exponential growth of data generation and the pressing need for energy-efficient computing solutions. These innovative memories, including RRAM, PCRAM, MRAM, and FeRAM, offer a tantalizing blend of speed, density, and non-volatility, making them attractive candidates for future memory hierarchies and neuromorphic architectures. As we navigate the data explosion era, these technologies hold the potential to revolutionize the way we process and store information, breaking free from the constraints of traditional von Neumann architectures. While challenges persist in areas such as scalability, endurance, and integration, the progress made in emerging memory technologies is paving the way for a paradigm shift in computing. In-memory computing and near-memory computing approaches, enabled by these novel memories, are poised to alleviate the memory bottleneck and unlock new frontiers in energy efficiency and computational performance. As we continue to explore the vast possibilities of these innovations, we are witnessing the dawn of a new era in electronics, where memory and computation converge,

redefining the boundaries of what is achievable in the digital world.

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